FAIRCHILD SEMICONDUCTOR™

May 2002

# FDS4953

## Dual 30V P-Channel PowerTrench® MOSFET

### General Description

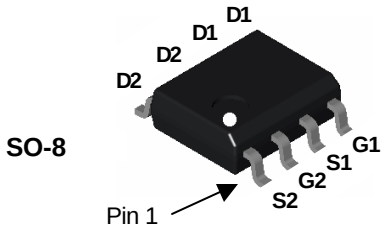
This P-Channel MOSFET is a rugged gate version of Fairchild Semiconductor's advanced PowerTrench process. It has been optimized for power management applications requiring a wide range of gave drive voltage ratings (4.5V – 25V).

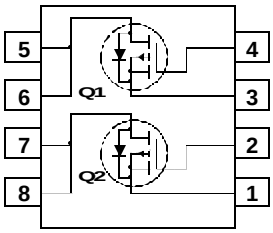
### Applications

- Power management
- Load switch
- Battery protection

### Features

- –5 A, –30 V $R_{DS(ON)}$ = 55 mΩ @ $V_{GS}$ = –10 V
  $R_{DS(ON)}$ = 95 mΩ @ $V_{GS}$ = –4.5 V
- Low gate charge (6nC typical)
- Fast switching speed
- High performance trench technology for extremely low $R_{DS(ON)}$
- High power and current handling capability




## Absolute Maximum Ratings $T_A$=25°C unless otherwise noted

| Symbol | Parameter | | Ratings | Units |
|---|---|---|---|---|
| $V_{DSS}$ | Drain-Source Voltage | | –30 | V |
| $V_{GSS}$ | Gate-Source Voltage | | ±20 | V |
| $I_D$ | Drain Current – Continuous | (Note 1a) | –5 | A |
| | – Pulsed | | –20 | |
| $P_D$ | Power Dissipation for Dual Operation | | 2 | W |
| $P_D$ | Power Dissipation for Single Operation | (Note 1a) | 1.6 | |
| | | (Note 1b) | 1 | |
| | | (Note 1c) | 0.9 | |
| $T_J$, $T_{STG}$ | Operating and Storage Junction Temperature Range | | –55 to +175 | °C |

## Thermal Characteristics

| | | | | |
|---|---|---|---|---|
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | (Note 1a) | 78 | °C/W |
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case | (Note 1) | 40 | °C/W |

## Package Marking and Ordering Information

| Device Marking | Device | Reel Size | Tape width | Quantity |
|---|---|---|---|---|
| FDS4953 | FDS4953 | 13" | 12mm | 2500 units |

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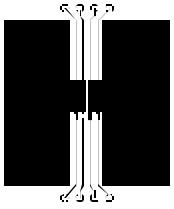
## Electrical Characteristics

$T_A$ = 25°C unless otherwise noted

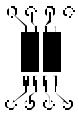
| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|---|---|---|---|---|---|---|
| **Off Characteristics** | | | | | | |
| $BV_{DSS}$ | Drain–Source Breakdown Voltage | $V_{GS}$ = 0 V, $I_D$ = –250 µA | –30 | | | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | $I_D$ = –250 µA, Referenced to 25°C | | –23 | | mV/°C |
| $I_{DSS}$ | Zero Gate Voltage Drain Current | $V_{DS}$ = –24 V, $V_{GS}$ = 0 V | | | –1 | µA |
| $I_{GSSF}$ | Gate–Body Leakage, Forward | $V_{GS}$ = –20 V, $V_{DS}$ = 0 V | | | –100 | nA |
| $I_{GSSR}$ | Gate–Body Leakage, Reverse | $V_{GS}$ = 20 V, $V_{DS}$ = 0 V | | | 100 | nA |
| **On Characteristics** (Note 2) | | | | | | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS}$ = $V_{GS}$, $I_D$ = –250 µA | –1 | –1.7 | –3 | V |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate Threshold Voltage Temperature Coefficient | $I_D$ = –250 µA, Referenced to 25°C | | 4.5 | | mV/°C |
| $R_{DS(on)}$ | Static Drain–Source On–Resistance | $V_{GS}$ = –10 V, $I_D$ = –5 A<br>$V_{GS}$ = –4.5 V, $I_D$ = –3.3 A<br>$V_{GS}$= –10 V, $I_D$ = –5 A, $T_J$=125°C | | 46<br>70<br>63 | 55<br>95<br>85 | mΩ |
| $I_{D(on)}$ | On–State Drain Current | $V_{GS}$ = –10 V, $V_{DS}$ = –5 V | –20 | | | A |
| $g_{FS}$ | Forward Transconductance | $V_{DS}$ = –5 V, $I_D$ = –5 A | | 10 | | S |
| **Dynamic Characteristics** | | | | | | |
| $C_{iss}$ | Input Capacitance | $V_{DS}$ = –15 V, $V_{GS}$ = 0 V, f = 1.0 MHz | | 528 | | pF |
| $C_{oss}$ | Output Capacitance | | | 132 | | pF |
| $C_{rss}$ | Reverse Transfer Capacitance | | | 70 | | pF |
| **Switching Characteristics** (Note 2) | | | | | | |
| $t_{d(on)}$ | Turn–On Delay Time | $V_{DD}$ = –15 V, $I_D$ = –1 A, $V_{GS}$ = –10 V, $R_{GEN}$ = 6 Ω | | 7 | 14 | ns |
| $t_r$ | Turn–On Rise Time | | | 13 | 24 | ns |
| $t_{d(off)}$ | Turn–Off Delay Time | | | 14 | 25 | ns |
| $t_f$ | Turn–Off Fall Time | | | 9 | 17 | ns |
| $Q_g$ | Total Gate Charge | $V_{DS}$ = –15 V, $I_D$ = –5 A, $V_{GS}$ = –5 V | | 6 | 9 | nC |
| $Q_{gs}$ | Gate–Source Charge | | | 2.2 | | nC |
| $Q_{gd}$ | Gate–Drain Charge | | | 2 | | nC |
| **Drain–Source Diode Characteristics and Maximum Ratings** | | | | | | |
| $I_S$ | Maximum Continuous Drain–Source Diode Forward Current | | | | –1.3 | A |
| $V_{SD}$ | Drain–Source Diode Forward Voltage | $V_{GS}$ = 0 V, $I_S$ = –1.3 A (Note 2) | | –0.8 | –1.2 | V |

**Notes:**

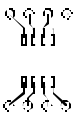
**1.** $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a) 78°C/W when mounted on a 0.5in² pad of 2 oz copper



b) 125°C/W when mounted on a 0.02 in² pad of 2 oz copper



c) 135°C/W when mounted on a minimum pad.

Scale 1 : 1 on letter size paper

**2.** Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%

## Typical Characteristics

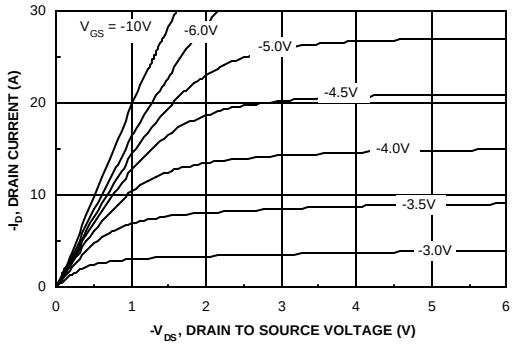



**Figure 1. On-Region Characteristics.**

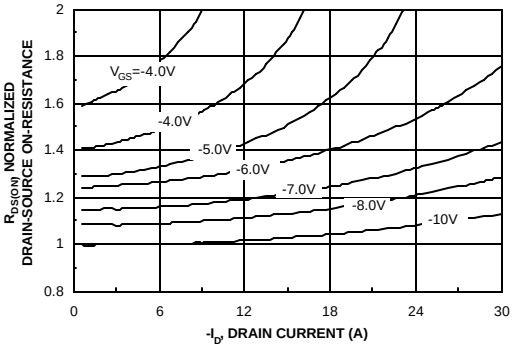



**Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.**

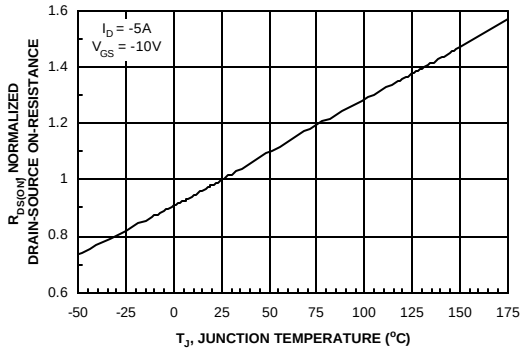



**Figure 3. On-Resistance Variation with Temperature.**

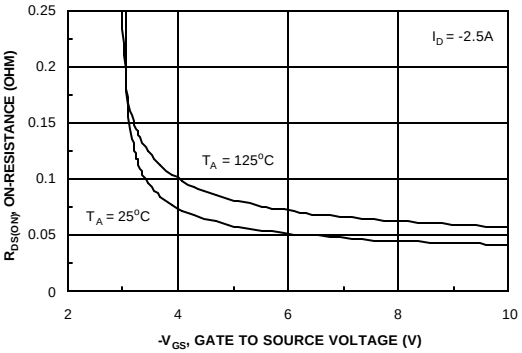



**Figure 4. On-Resistance Variation with Gate-to-Source Voltage.**

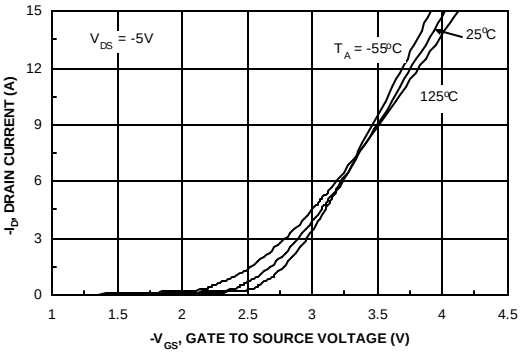



**Figure 5. Transfer Characteristics.**

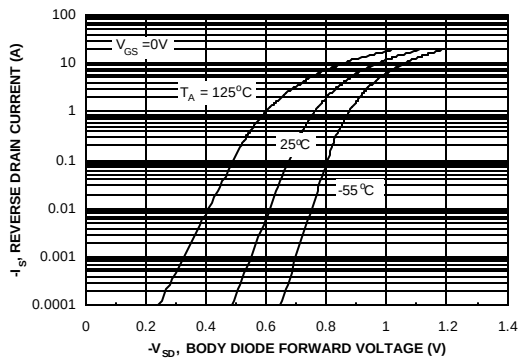



**Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.**

## Typical Characteristics

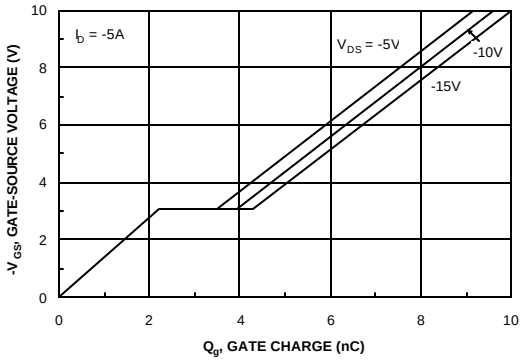



**Figure 7. Gate Charge Characteristics.**

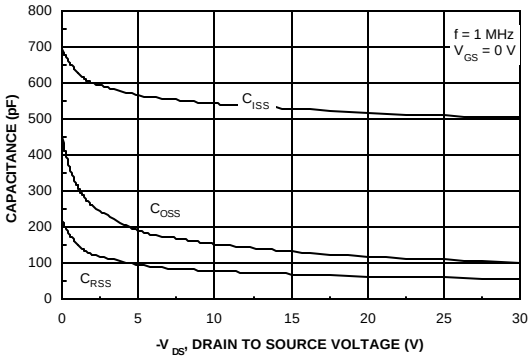



**Figure 8. Capacitance Characteristics.**

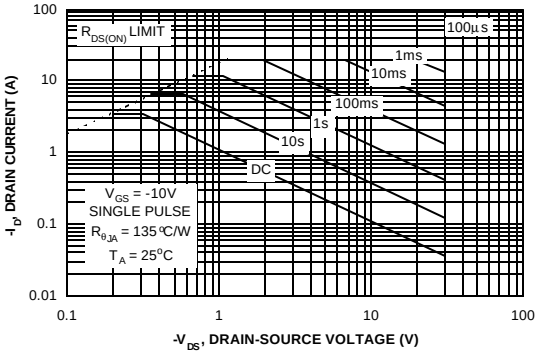



**Figure 9. Maximum Safe Operating Area.**

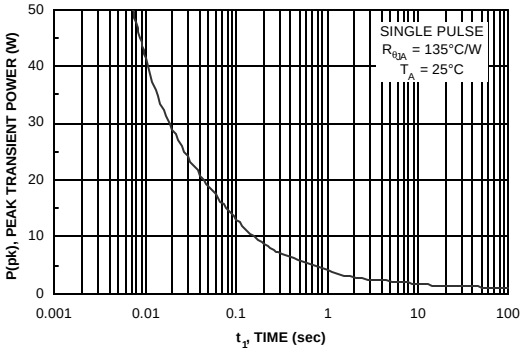



**Figure 10. Single Pulse Maximum Power Dissipation.**

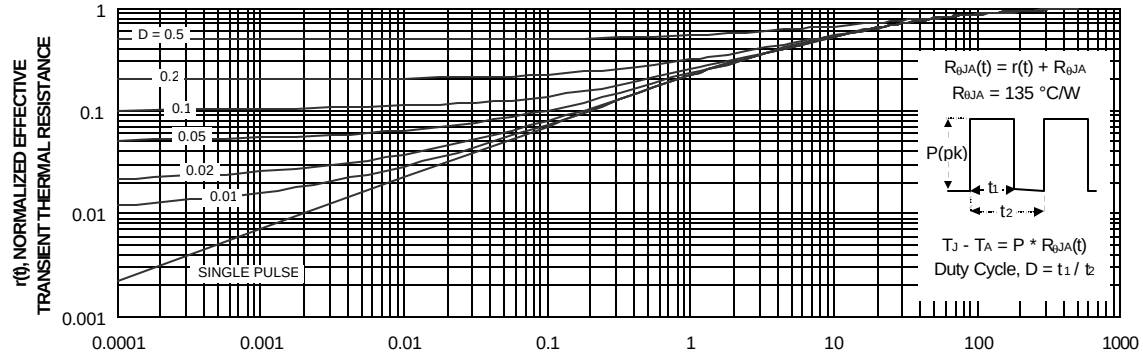



**Figure 11. Transient Thermal Response Curve.**

**Thermal characterization performed using the conditions described in Note 1c.**
**Transient thermal response will change depending on the circuit board design.**

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